捷多邦,专业PCB打样工厂 54A@介6652度74AC16652 16-BIT BUS TRANSCEIVERS AND REGISTERS WITH 3-STATE OUTPUTS

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- Members of the Texas Instruments
 Widebus ™ Family
- Independent Registers and Enables for A and B Buses
- Multiplexed Real-Time and Stored Data
- Flow-Through Architecture Optimizes
 PCB Layout
- Distributed V_{CC} and GND Pin Configurations Minimize High-Speed Switching Noise
- EPIC ™ (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL) Packages Using 25-mil Center-to-Center Pin Spacings and 380-mil Fine-Pitch Ceramic Flat (WD) Packages Using 25-mil Center-to-Center Pin Spacings

description

The 'AC16652 are 16-bit bus transceivers that consist of D-type flip-flops and control circuitry arranged for multiplexed transmission of data directly from the data bus or from the internal storage registers. They can be used as two 8-bit transceivers or one 16-bit transceiver.

Complementary output-enable (OEAB and OEBA) inputs are provided to control the transceiver functions. Select-control (SAB and SBA) inputs are provided to select whether real-time or stored data is transferred. A low input level selects real-time data, and a high input level selects stored data. The circuitry used for select control eliminates the typical decoding glitch that occurs in a multiplexer during the transition between stored and real-time data. Figure 1 illustrates the four fundamental bus-management functions that can be performed with the 'AC16652.

54AC16652... WD PACKAGE 74AC16652... DL PACKAGE (TOP VIEW)

		_			
10EAB	1	U	56	b	1OEBA
1CLKAB	2		55	6	1CLKBA
1SAB	3		54	6	1SBA
GND [4		53	6	GND
1A1 [5		52		1B1
1A2 [6		51		1B2
v _{cc} [7		50		V_{CC}
1A3 [8		49		1B3
1A4 🛚	9		48	1	1B4
1A5 🛚	10		47		1B5
GND [11		46		GND
1A6 🛚	12		45		1B6
1A7	13		44	0	1B7
1A8 [14		43	p	1B8
2A1	15		42		2B1
2A2	16		41	1	2B2
2A3 🛚	17		40	1	2B3
GND [18		39	P	GND
2A4	19		38		2B4
2A5	20		37	0	2B5
2A6	21		36	0	2B6
V _{CC}	22		35	0	VCC
2A7	23		34		2B7
2A8	24		33		2B8
GND	25		32	p	GND
2SAB	26		31	1	2SBA
2CLKAB	27		30		2CLKBA
20EAB [28		29		2OEBA

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description (continued)

Data on the A or B bus, or both, can be stored in the internal D flip-flops by low-to-high transitions at the appropriate clock (CLKAB or CLKBA) inputs regardless of the levels on the select-control or output-enable inputs. When SAB and SBA are in the real-time transfer mode, it is also possible to store data without using the internal D-type flip-flops by simultaneously enabling OEAB and OEBA. In this configuration, each output reinforces its input. Thus, when all other data sources to the two sets of bus lines are at high impedance, each set of bus lines remains at its last state.

The 74AC16652 is packaged in TI's shrink small-outline package (DL), which provides twice the I/O pin count and functionality of standard small-outline packages in the same printed-circuit-board area.

The 54AC16652 is characterized for operation over the full military temperature range of –55°C to 125°C. The 74AC16652 is characterized for operation from –40°C to 85°C.

FUNCTION TABLE

		INPU	гѕ			DATA	A 1/0†	ODERATION OR FUNCTION
OEAB	OEBA	CLKAB	CLKBA	SAB	SBA	A1–A8	B1-B8	OPERATION OR FUNCTION
L	Н	L	L	Х	Х	Input	Input	Isolation
L	Н	\uparrow	\uparrow	X	X	Input	Input	Store A and B data
Х	Н	↑	L	Х	Х	Input	Unspecified [‡]	Store A, hold B
Н	Н	\uparrow	1	X‡	X	Input	Output	Store A in both registers
L	Х	L	1	Х	Х	Unspecified [‡]	Input	Hold A, store B
L	L	\uparrow	1	X	X [‡]	Output	Input	Store B in both registers
L	L	Χ	Χ	Х	L	Output	Input	Real-time B data to A bus
L	L	Χ	L	X	Н	Output	Input	Stored B data to A bus
Н	Н	Х	Х	L	Х	Input	Output	Real-time A data to B bus
Н	Н	L	Χ	Н	X	Input	Output	Stored A data to B bus
Н	L	L	L	Н	Н	Output	Output	Stored A data to B bus and stored B data to A bus

[†] The data-output functions may be enabled or disabled by a variety of level combinations at OEAB or OEBA. Data-input functions are always enabled; i.e., data at the bus terminals is stored on every low-to-high transition on the clock inputs.

Select control = H; clocks must be staggered in order to load both registers.



[‡] Select control = L; clocks can occur simultaneously.

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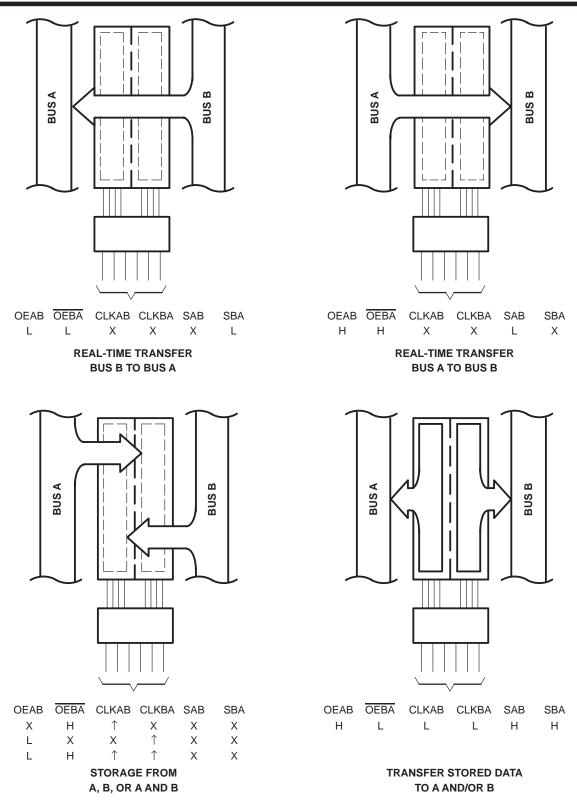
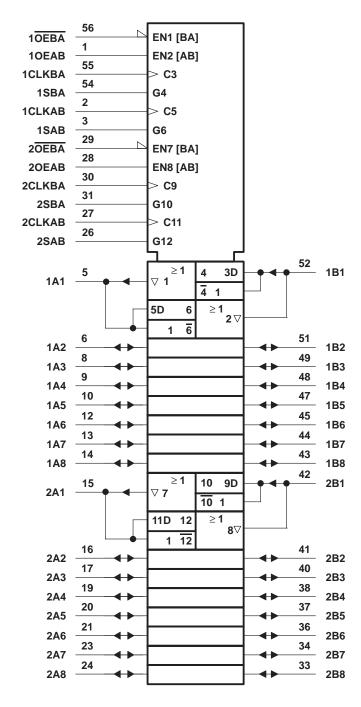


Figure 1. Bus-Management Functions



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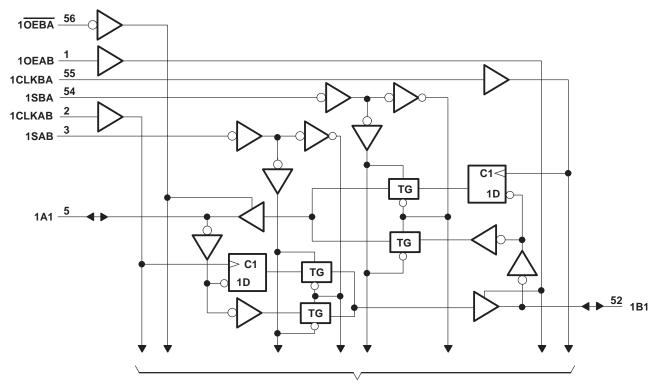
logic symbol†



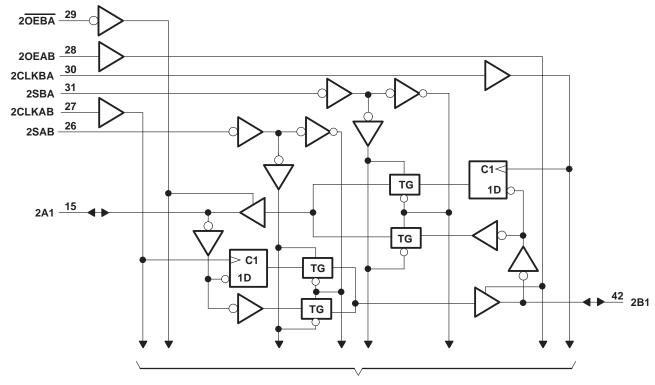
[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



logic diagram (positive logic)



To Seven Other Channels



To Seven Other Channels

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 7 V
Input voltage range, V _I (see Note 1)—C	$0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Output voltage range, V _O (see Note 1)–C	$0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{CC})	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V _{CC} or GND	±400 mA
Maximum package power dissipation at T _A = 55°C (in still air) (see Note 2): DL package	1.4 W
Storage temperature range, T _{stq}	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

recommended operating conditions (see Note 3)

			54	AC1665	2	74	AC1665	2	UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNII
Vcc	Supply voltage (see Note 4)		3	5	5.5	3	5	5.5	V
		V _{CC} = 3 V	2.1			2.1			
V_{IH}	High-level input voltage	$V_{CC} = 4.5 \text{ V}$	3.15			3.15			V
	V _{CC} = 5.5 V	3.85			3.85				
		VCC = 3 V	T		0.9			0.9	
V_{IL}	Low-level input voltage	V _{CC} = 4.5 V		S	1.35			1.35	V
		V _{CC} = 5.5 V		Q.	1.65			1.65	
VI	Input voltage		0	6	Vcc	0		VCC	V
٧o	Output voltage		0.4	3	Vcc	0		VCC	V
		VCC = 3 V	700		-4			-4	
loh	High-level output current	V _{CC} = 4.5 V	7		-24			-24	mA
		V _{CC} = 5.5 V			-24			-24	
		VCC = 3 V			12			12	
I_{OL}	Low-level output current	V _{CC} = 4.5 V			24			24	mA
		V _{CC} = 5.5 V			24			24	
Δt/Δν	Input transition rise or fall rate	•	0		10	0		10	ns/V
TA	Operating free-air temperature		-55		125	-40		85	°C

NOTES: 3. Unused inputs must be held high or low to prevent them from floating.

4. All $V_{\hbox{CC}}$ and GND pins must be connected to the proper voltage power supply.



^{2.} The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DAI	DAMETER	TEST COMPLTIONS	V	T,	A = 25°C		54AC1	6652	74AC1	6652	LINUT		
PAI	RAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT		
			3 V	2.9			2.9		2.9				
		I _{OH} = -50 μA	4.5 V	4.4			4.4		4.4				
			5.5 V	5.4			5.4		5.4				
\/a		I _{OH} = -4 mA	3 V	2.58			2.4		2.48		V		
VOH		I _{OH} = -24 mA	4.5 V	3.94			3.7		3.8		V		
		IOH = -24 IIIA	5.5 V	4.94			4.7		4.8				
		I _{OH} = -50 mA [†]	5.5 V				3.85	EN					
		I _{OH} = -75 mA [†]	5.5 V					FV	3.85				
			3 V			0.1	4	0.1		0.1			
		I _{OL} = 50 μA				0.1	,C	0.1		0.1			
			5.5 V			0.1	79	0.1		0.1			
\/a.		I _{OL} = 12 mA	3 V			0.36	PAC	0.5		0.44	· /		
VOL	0.4 ** A	101 - 24 mA	4.5 V			0.36	_	0.5		0.44			
		I _{OL} = 24 mA	5.5 V			0.36		0.5		0.44			
		I _{OL} = 50 mA [†]	5.5 V					1.65					
		I _{OL} = 75 mA [†]	5.5 V							1.65			
II	Control inputs	V _I = V _{CC} or GND	5.5 V			±0.1		±1		±1	μΑ		
loz	A or B ports‡	$V_O = V_{CC}$ or GND	5.5 V			±0.5		±10		±5	μΑ		
Icc		$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		160		80	μΑ		
Ci	Control inputs	V _I = V _{CC} or GND	5 V		4						pF		
C _{io}	A or B ports	$V_O = V_{CC}$ or GND	5 V		12						pF		

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 2)

		T _A = 2	25°C	54AC1	6652	74AC1	6652	UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
fclock	Clock frequency	0	55	0	55	0	55	MHz
t _W	Pulse duration, CLKAB or CLKBA high or low	9		9	N.	9		ns
t _{su}	Setup time, A before CLKAB↑ or B before CLKBA↑	7		7		7		ns
th	Hold time, A after CLKAB↑ or B after CLKBA↑	0		0		0		ns

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 2)

		T _A = 25°C		54AC16652		74AC16652		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
fclock	Clock frequency	0	95	0	95	0	95	MHz
t _W	Pulse duration, CLKAB or CLKBA high or low	5		5	140	5		ns
t _{su}	Setup time, A before CLKAB↑ or B before CLKBA↑	4.5		4.5		4.5		ns
th	Hold time, A after CLKAB↑ or B after CLKBA↑	0		0		0		ns



 $[\]mbox{‡ For I/O ports, the parameter I}_{\mbox{OZ}}$ includes the input leakage current.

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switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 2)

PARAMETER	FROM	то	T,	Δ = 25°C	;	54AC1	6652	74AC1	6652	UNIT	
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	IAX	
f _{max}			55			55		55		MHz	
t _{PLH}	A or B	B or A	3.6	10.4	13.7	3.6	17.1	3.6	15.6	ns	
^t PHL	A OF B	BOIA	4.1	10.9	14.3	4.1	16.3	4.1	15.4	ns	
^t PLH	CLKBA or CLKAB	A or B	5.1	13.6	17.3	5.1	21.2	5.1	19.5	ns	
t _{PHL}	CLNBA OI CLNAB	AUIB	5.4	13.5	17.2	5.4	19.9	5.4	18.8	115	
t _{PLH}	SBA or SAB	A or B	5.8	15.0	18.7	5.8	23.3	5.8	21.4	ns	
t _{PHL}	(with A or B high)	AOIB	5.4	13.1	16.7	5.4	19.1	5.4	18.1	115	
t _{PLH}	SBA or SAB	SBA or SAB A or B	4.2	11.8	15.2	4.2 4	18.9	4.2	17.4	ns	
t _{PHL}	(with A or B low)	AOIB	5.9	14.4	18.3	5.9	21.7	5.9	20.3	115	
^t PZH	OEBA	А	4.2	11.8	15.1	4.2	18.8	4.2	17.2	ns	
tpzL	OEBA	A	6	16.2	20.6	6) \{	25.3	6	23.5	115	
^t PHZ	OED4	А	4.6	8.1	10	4.6	10.9	4.6	10.6	ns	
t _{PLZ}	OEBA	A	4.4	7.6	9.6	4.4	10.6	4.4	10.3	115	
^t PZH	OFAR	В	4.1	11.5	14.6	4.1	18.1	4.1	16.6	ns	
t _{PZL}	OEAB	ט	6	16.0	20	6	24.6	6	22.7	115	
t _{PHZ}	PH7	В	4.3	7.2	9	4.3	9.7	4.3	9.5	ns	
tPLZ	OEAB	ט	3.9	6.7	8.6	3.9	9.2	3.9	9.1	115	

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 2)

PARAMETER	FROM	то	T,	λ = 25°C	;	54AC1	6652	74AC1	6652	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
f _{max}			95			95		95		MHz
t _{PLH}	A or B	B or A	2.7	6.1	8.8	2.7	10.7	2.7	9.9	ns
t _{PHL}	AOIB	BOIA	3	6.3	9.2	3	10.8	3	10.2	115
t _{PLH}	CLKBA or CLKAB	A or B	3.9	7.8	10.9	3.9	13.3	3.9	12.2	ns
^t PHL	CERBA OF CERAB	AOIB	4.2	7.8	11.1	4.2	13.2	4.2	12.3	115
^t PLH	SBA or SAB	A or B	4.5	8.8	12.1	4.5	15	4.5	13.8	ns
t _{PHL}	(with A or B high)	AUID	4.1	7.7	11	4.1	12.9	4.1	12.1	12.1
t _{PLH}	SBA or SAB (with A or B low)	A or B	3.1	6.7	9.7	3.1	11.9	3.1	11	ns
^t PHL		AOIB	4.6	8.8	12.2	4.6	14.9	4.6	13.8	115
^t PZH	OEBA	А	3.1	6.7	9.5	3.1	11.6	3.1	10.7	ns
^t PZL	OEBA	٨	4.5	8.3	11.8	4.5	14.4	4.5	13.2	115
^t PHZ	OEBA	А	4.6	6.5	8.3	4.6	9	4.6	8.8	ns
t _{PLZ}	OEBA	A	4.1	6.1	8.1	4.1	9.1	4.1	8.7	115
^t PZH	OFAR	В	3.1	6.6	9.3	3.1	11.3	3.1	10.5	ns
^t PZL	OEAB		4.6	8.2	11.6	4.6	14.1	4.6	13	115
^t PHZ	OFAR	В	4.2	5.9	7.7	4.2	8.3	4.2	8	ns
t _{PLZ}	OEAB	, b	3.7	5.5	7.4	3.7	8.3	3.7	7.8	113

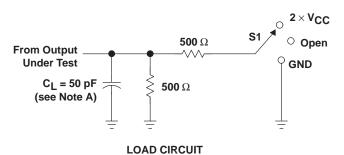


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operating characteristics, V_{CC} = 5 V, T_A = 25°C

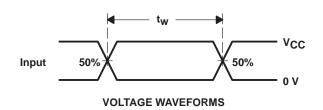
	PARAMETER			TEST CONDITIONS		
	Dower dissipation conscitance per transceiver	Outputs enabled	C ₁ = 50 pF,	f = 1 MHz	57	pF
Cbq	Power dissipation capacitance per transceiver	Outputs disabled	CL = 50 pr,	I = I IVITIZ	13	Pr

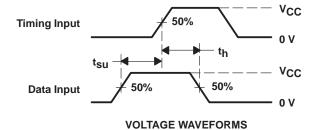
PARAMETER MEASUREMENT INFORMATION

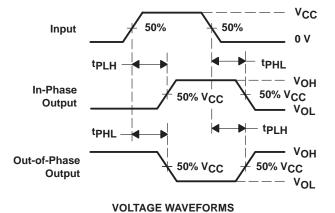


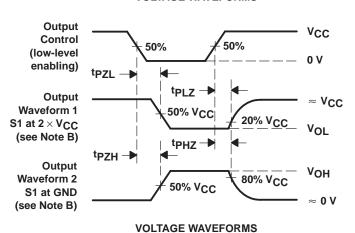
TEST	S1
tPLH/tPHL	Open
tPLZ/tPZL	2×V _{CC}
tPHZ/tPZH	GND











NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_r = 3 \text{ ns}$, $t_f = 3 \text{ ns}$.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms

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